

<b>Notice of References Cited</b>	Application/Control No. 10/613,096	Applicant(s)/Patent Under Reexamination WATABE ET AL.	
	Examiner Alex Epshteyn	Art Unit 3713	Page 1 of 4

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<b>Notice of References Cited</b>	Application/Control No. 10/613,096	Applicant(s)/Patent Under Reexamination WATABE ET AL.	
	Examiner Alex Epshteyn	Art Unit 3713	Page 2 of 4

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<b>Notice of References Cited</b>	Application/Control No. 10/613,096	Applicant(s)/Patent Under Reexamination WATABE ET AL.	
	Examiner Alex Epshteyn	Art Unit 3713	Page 3 of 4

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	Examiner Alex Epshteyn	Art Unit 3713	Page 4 of 4

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